

**Features**

- CRM(CQ) Super\_Junction technology
- Much lower Ron\*A performance for On-state efficiency
- Better efficiency due to very low FOM

**Product Summary**

VDS	650V
R <sub>DS(on)</sub> _typ	0.16Ω
I <sub>D</sub>	20A

**Applications**

- LED/LCD/PDP TV and monitor Lighting
- Solar/Renewable/UPS-Micro Inverter System
- Charger
- Power Supply

**100% DVDS Tested****100% Avalanche Tested****Package Marking and Ordering Information**

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRJF190N65GC	CRJF190N65GC	TO220F	Tube	N/A	N/A	50pcs

**Absolute Maximum Ratings**

Parameter	Symbol	Value	Unit
Drain-source voltage	V <sub>DS</sub>	650	V
Continuous drain current T <sub>C</sub> = 25°C	I <sub>D</sub>	20	A
T <sub>C</sub> = 100°C		14.0	
Pulsed drain current (T <sub>C</sub> = 25°C, t <sub>p</sub> limited by T <sub>jmax</sub> )	I <sub>D</sub> pulse	80	A
Avalanche energy, single pulse (L=60mH, R <sub>g</sub> =30Ω)	E <sub>AS</sub>	320	mJ
MOSFET dv/dt ruggedness	dv/dt	50	V/ns
Gate-Source voltage	V <sub>GS</sub>	±30	V
Power dissipation (T <sub>C</sub> = 25°C)	P <sub>tot</sub>	29	W
Continuous diode forward current(T <sub>C</sub> = 25°C)	I <sub>S</sub>	20	A
Diode pulse current <sup>2)</sup> (T <sub>C</sub> = 25°C)	I <sub>S</sub> pulse	80	A
Recovery diode dv/dt <sup>3)</sup>	dv/dt	50	V/ns
Operating junction and storage temperature	T <sub>j</sub> , T <sub>stg</sub>	-55...+150	°C

1) Limited by T<sub>j,max</sub>. Maximum Duty Cycle D = 0.50; TO-220 equivalent2) Pulse width t<sub>p</sub> limited by T<sub>j,max</sub>

3) Identical low side and high side switch with identical RG



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CRJF190N65GC

SJMOS N-MOSFET 650V, 0.16Ω, 20A

**Thermal Resistance**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Thermal resistance, junction – case	R <sub>thJC</sub>	-	3.08	4.31	°C/W	
Thermal resistance, junction – ambient	R <sub>thJA</sub>	-	-	82	°C/W	

**Electrical Characteristic (at T<sub>j</sub> = 25 °C, unless otherwise specified)**

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

**Static Characteristic**

Drain-source breakdown voltage	BV <sub>DSS</sub>	650	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
Gate threshold voltage	V <sub>GS(th)</sub>	3.2	3.7	4.2	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
Zero gate voltage drain current	I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V T <sub>j</sub> =25°C T <sub>j</sub> =150°C
-	-	-	20	-	-	
Gate-source leakage current	I <sub>GSS</sub>	-	0.3	80	nA	V <sub>GS</sub> =±30V, V <sub>DS</sub> =0V
Drain-source on-state resistance	R <sub>DS(on)</sub>	-	0.16	0.19	Ω	V <sub>GS</sub> =10V, I <sub>D</sub> =10A, T <sub>j</sub> =25°C T <sub>j</sub> =150°C
-	-	-	0.43	-	-	
Transconductance	g <sub>f</sub>	-	24	-	S	V <sub>DS</sub> =20V, I <sub>D</sub> =10A

**Dynamic Characteristic**

Input Capacitance	C <sub>iss</sub>	-	1788	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =100V, f=1MHz
Output Capacitance	C <sub>oss</sub>	-	65	-		
Reverse Transfer Capacitance	C <sub>rss</sub>	-	2.35	-		
Gate Total Charge	Q <sub>G</sub>	-	49	-	nC	V <sub>GS</sub> =10V, V <sub>DS</sub> =480V, I <sub>D</sub> =10A
Gate-Source charge	Q <sub>gs</sub>	-	11.5	-		
Gate-Drain charge	Q <sub>gd</sub>	-	20	-		
Turn-on delay time	t <sub>d(on)</sub>	-	39	-	ns	T <sub>j</sub> =25°C, V <sub>GS</sub> =10V, I <sub>D</sub> =10A, V <sub>DS</sub> =400V, R <sub>g</sub> =25Ω
Rise time	t <sub>r</sub>	-	26	-		
Turn-off delay time	t <sub>d(off)</sub>	-	156	-		
Fall time	t <sub>f</sub>	-	48	-		
Gate resistance	R <sub>G</sub>	-	0.9	-	Ω	f=1MHz



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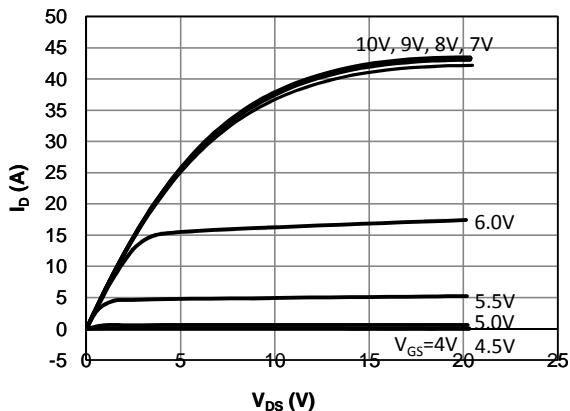
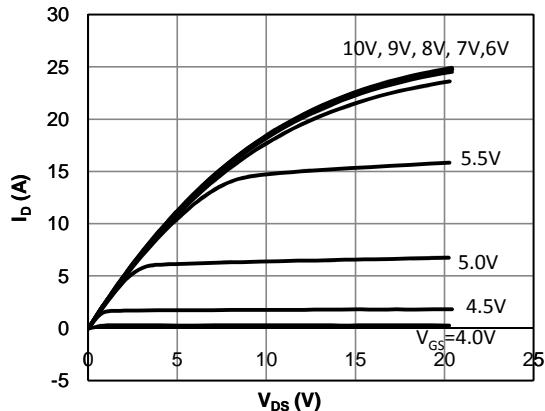
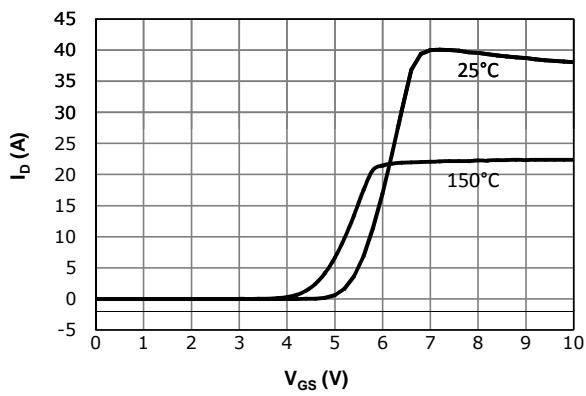
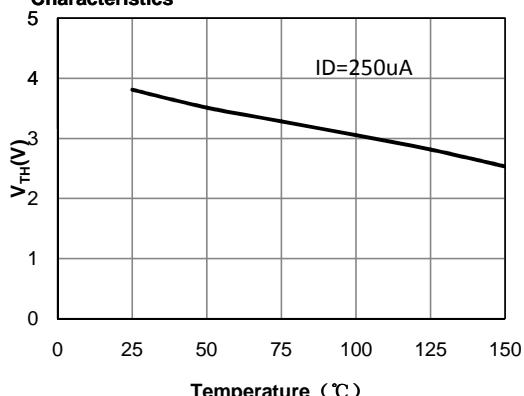
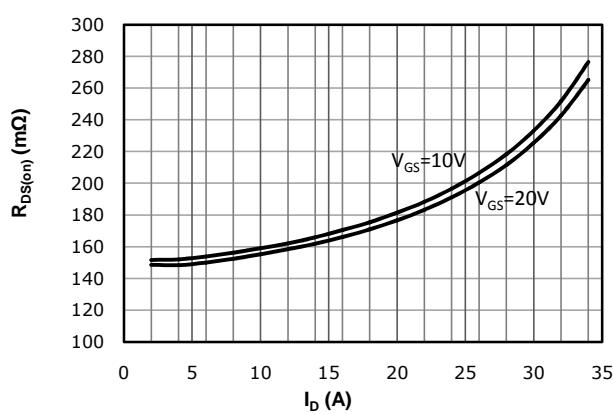
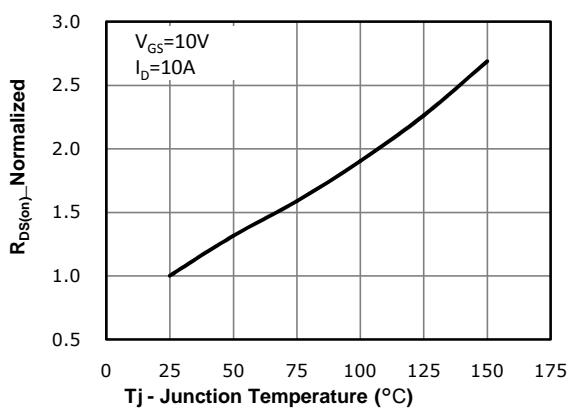
CRJF190N65GC

SJMOS N-MOSFET 650V, 0.16Ω, 20A

### Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V <sub>SD</sub>	0.5	0.84	1	V	V <sub>GS</sub> =0V, I <sub>SD</sub> =10A
Body Diode Reverse Recovery Time	t <sub>rr</sub>	-	303	-	ns	I <sub>sd</sub> =10A dI/dt=100A/us
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	-	3.76	-	uC	V <sub>ds</sub> =100V

## Typical Performance Characteristics

**Fig 1. Output Characteristics (T<sub>j</sub>=25°C)**

**Fig 2. Output Characteristics (T<sub>j</sub>=150°C)**

**Fig 3: Transfer Characteristics**

**Fig 4: V<sub>TH</sub> Vs T<sub>j</sub> Temperature Characteristics**

**Fig 5: R<sub>dson</sub> Vs I<sub>DS</sub> Characteristics(T<sub>c</sub>=25°C)**

**Fig 6: R<sub>d(on)</sub> vs. Temperature**


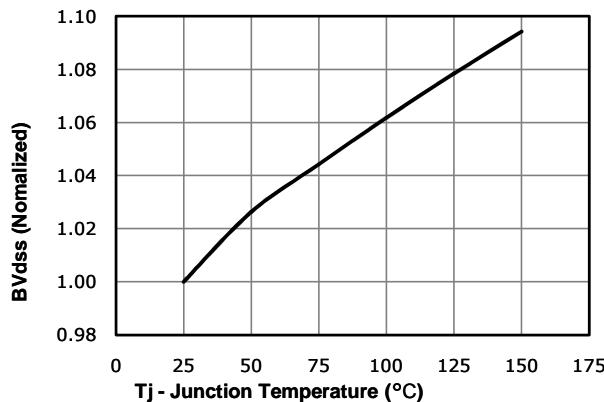
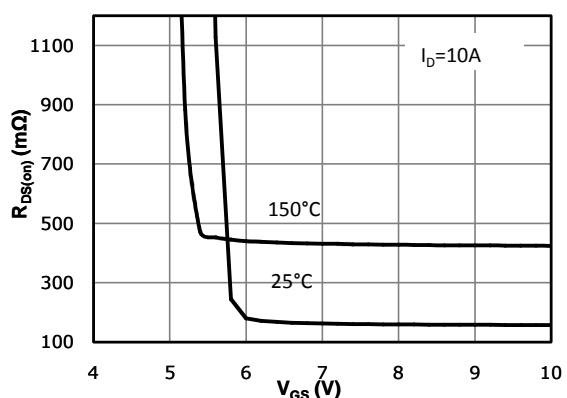
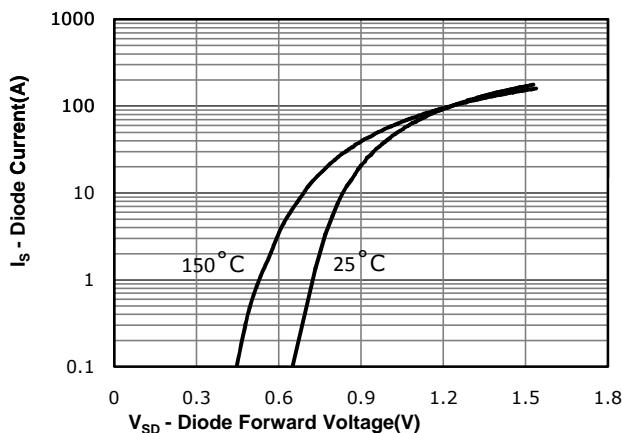
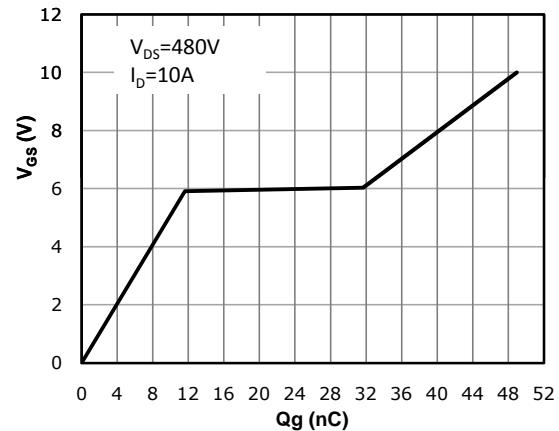
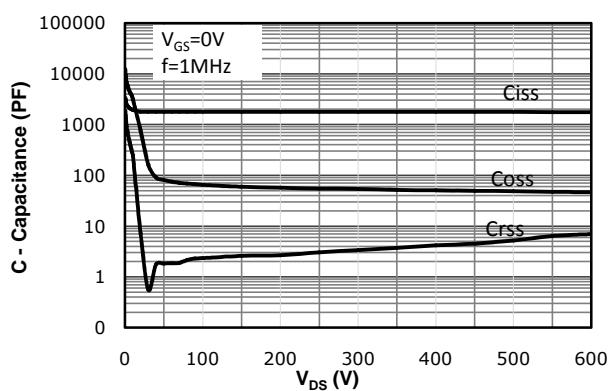
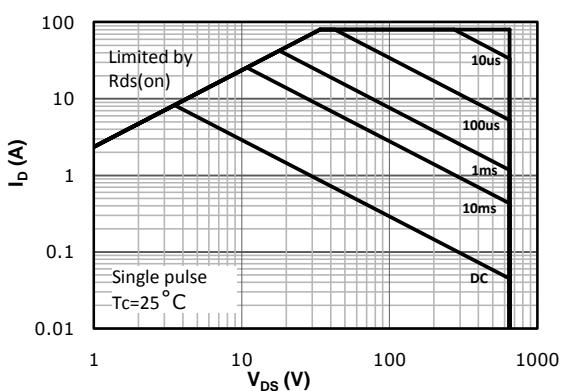
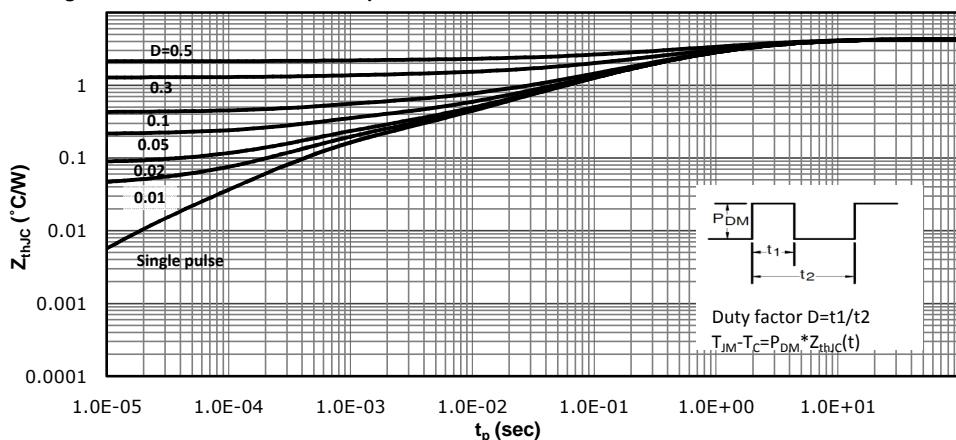
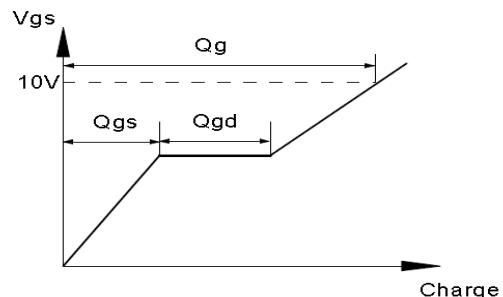
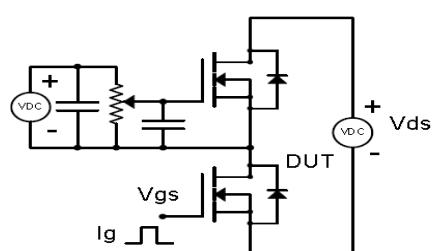
**Fig 7: BV<sub>DSS</sub> vs. Temperature**

**Fig 8: R<sub>d(on)</sub> vs Gate Voltage**

**Fig 9: Body-diode Forward Characteristics**

**Fig 10: Gate Charge Characteristics**

**Fig 11: Capacitance Characteristics**

**Fig 12: Safe Operating Area**


Fig 13: Max. Transient Thermal Impedance

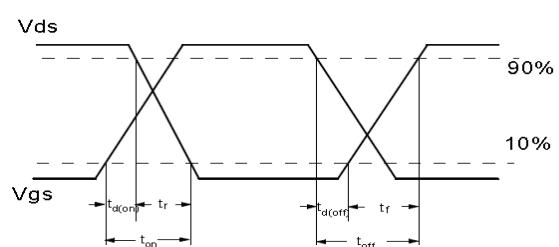
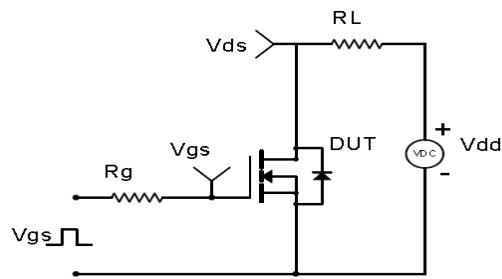


**Test Circuit & Waveform**

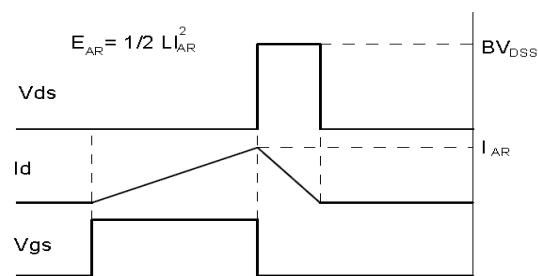
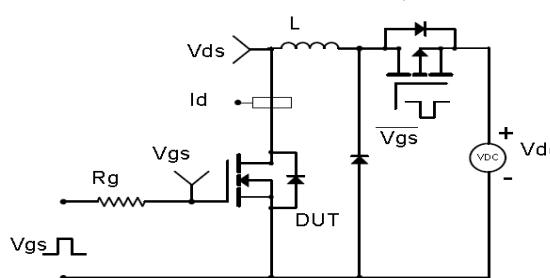
Gate Charge Test Circuit &amp; Waveform



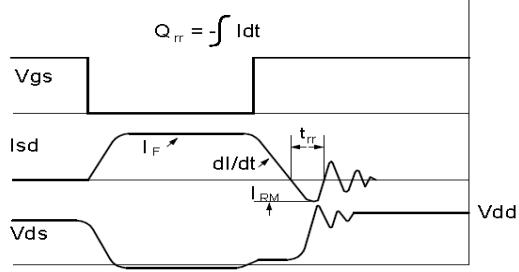
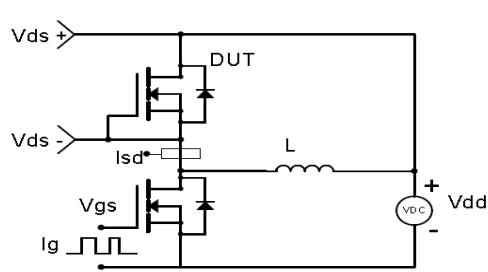
Resistive Switching Test Circuit &amp; Waveforms

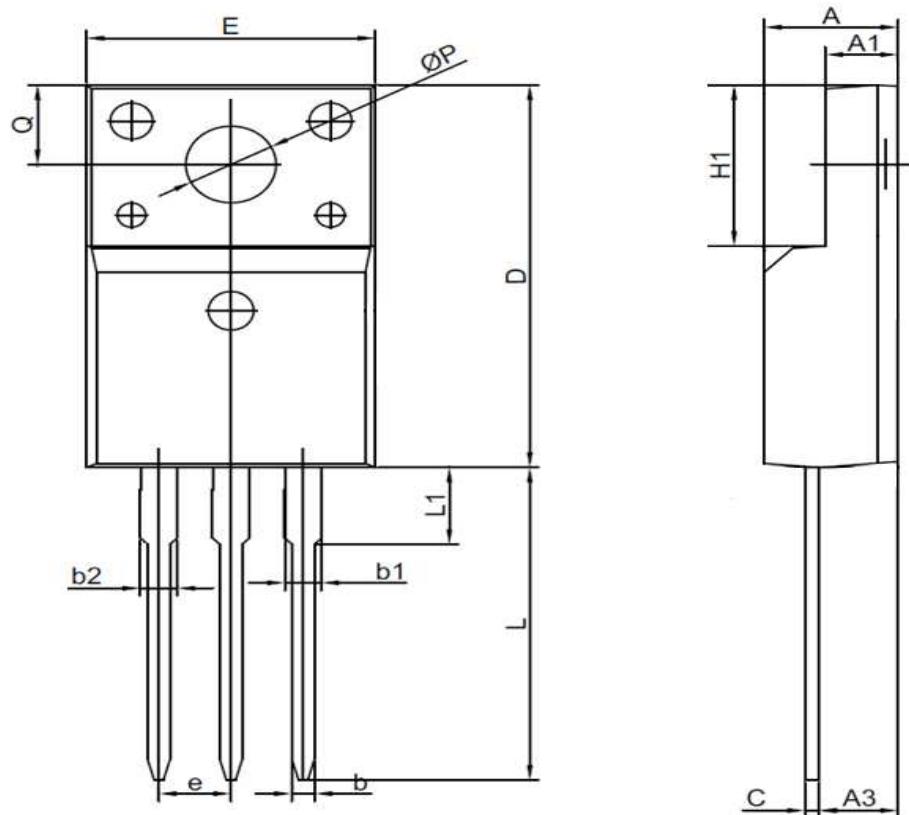


Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



Diode Recovery Test Circuit &amp; Waveforms



**Package Outline: TO-220F**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	4.30	4.90	0.169	0.193
A1	2.34	2.87	0.092	0.113
A3	2.20	2.96	0.087	0.117
b	0.60	0.90	0.024	0.035
b1	0.95	1.45	0.037	0.057
b2	1.15	1.55	0.045	0.061
c	0.40	0.70	0.016	0.028
D	15.50	16.17	0.610	0.637
e	2.54 BSC		0.100 BSC	
E	9.70	10.66	0.382	0.420
H1	6.70 REF		0.264 REF	
L	12.46	13.75	0.491	0.541
L1	2.80	3.80	0.110	0.150
Q	3.05	3.55	0.120	0.140
P	2.98	3.38	0.117	0.133

## Marking



NOTE:
NXBBAAAAY
X —Assembly location code
BB —Fab code
AAAA —Lot code
Y —Bin code

## Revision History

Revison	Date	Major changes
1.0	2019-8-13	Release of formal version
2.0	2022-4-28	Update Cxss and package outline; Add MOSFET dv/dt ruggedness, Recovery diode dv/dt, Continuous diode forward current, Diode pulse current; 增加电气引脚描述

## Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.